

ABSTRACT OF THE DISCLOSURE

A buffer layer of aluminum nitride (AlN) about 25 nm thick is provided on a sapphire substrate. An n⁺ layer of a high carrier density, which is about 4.0 μm thick and which is made of GaN doped with silicon (Si), is formed on the buffer layer. An intermediate layer of non-doped In_xGa_{1-x}N ($0 < x < 1$) about 3000 Å thick is formed on the high carrier density n⁺ layer. Then, an n-type clad layer of GaN about 250Å thick is laminated on the intermediate layer. Further, three well layers of 10 Ga_{0.8}In_{0.2}N about 30Å thick each and two barrier layers of GaN about 70Å thick each are laminated alternately on the n-type clad layer to thereby form a light-emitting layer of a structure with two multilayer quantum well (MQW) cycles.

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